Notice of References Cited

Application/Control No. 10/043,701	Reexaminati	Applicant(s)/Patent Under Reexamination PADHI ET AL.		
Examiner	Art Unit			
Harry D Wilkins, III	1742		Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	π	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	a					
	R			White the second		
	S	-				
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	Skoog et al, Analytical Chemistry: Chapter 19: "Applications of Potentiometry", Saunders College Publishing, Seventh Edition, 1996, pp. 412-429.			
	٧				
	w				
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.